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EPC2102 – Enhancement-Mode GaN Power Transistor Half-Bridge

V_{DS} , 60 V

$R_{DS(on)}$, 4.9 mΩ

I_D , 30 A



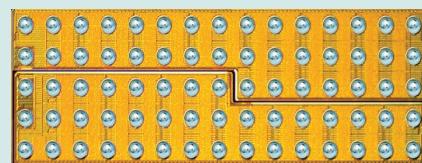
RoHS (Pb) Halogen-Free

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Maximum Ratings			
DEVICE	PARAMETER	VALUE	UNIT
Q1 & Q2	V_{DS}	Drain-to-Source Voltage (Continuous)	60
		Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	72
	I_D	Continuous ($T_A = 25^\circ\text{C}$, $R_{\theta JA} = 15^\circ\text{C}/\text{W}$)	30
		Pulsed (25°C , $T_{PULSE} = 300 \mu\text{s}$)	220
	V_{GS}	Gate-to-Source Voltage	6
		Gate-to-Source Voltage	-4
	T_J	Operating Temperature	-40 to 150
	T_{STG}	Storage Temperature	-40 to 150

Thermal Characteristics			
	PARAMETER	TYP	UNIT
Q1 & Q2	$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.3
	$R_{\theta JB}$	Thermal Resistance, Junction to Board	2.2
	$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	42

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details



EPC2102 eGaN® ICs are supplied only in passivated die form with solder bumps
Die Size: 6.05 mm x 2.3 mm

Applications

- High Frequency DC-DC

Benefits

- High Frequency Operation
- Ultra High Efficiency
- High Density Footprint

www.epc-co.com/epc/Products/eGaNFETsandICs/EPC2102.aspx

Static Characteristics						
DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX
Q1 & Q2	BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}$, $I_D = 0.6 \text{ mA}$	60		
	I_{DSS}	Drain-Source Leakage	$V_{DS} = 48 \text{ V}$, $V_{GS} = 0 \text{ V}$		0.008	0.4
	I_{GS}	Gate-to-Source Forward Leakage	$V_{GS} = 5 \text{ V}$		0.015	7
		Gate-to-Source Reverse Leakage	$V_{GS} = -4 \text{ V}$		0.008	0.4
	$V_{GS(\text{TH})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 7 \text{ mA}$	0.8	1.3	2.5
	$R_{DS(\text{on})}$	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}$, $I_D = 20 \text{ A}$		3.6	4.9
	V_{SD}	Source-Drain Forward Voltage	$I_S = 0.5 \text{ A}$, $V_{GS} = 0 \text{ V}$		1.7	

Dynamic Characteristics							
DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Q1	C_{ISS}	Input Capacitance	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$		850	1020	pF
	C_{RSS}	Reverse Transfer Capacitance			11		
	C_{OSS}	Output Capacitance			500	750	
	$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0 \text{ to } 30\text{ V}, V_{GS} = 0\text{ V}$		695		
	$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			863		
	Q_G	Total Gate Charge	$V_{DS} = 30\text{ V}, V_{GS} = 5\text{ V}, I_D = 20\text{ A}$		8	11	nC
	Q_{GS}	Gate-to-Source Charge	$V_{DS} = 30\text{ V}, I_D = 20\text{ A}$		2.5		
	Q_{GD}	Gate-to-Drain Charge			1.5		
	$Q_{G(TH)}$	Gate Charge at Threshold			1.7		
	Q_{OSS}	Output Charge	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$		26	39	
	Q_{RR}	Source-Drain Recovery Charge			0		
Q2	C_{ISS}	Input Capacitance	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$		850	1020	pF
	C_{RSS}	Reverse Transfer Capacitance			11		
	C_{OSS}	Output Capacitance			610	915	
	$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0 \text{ to } 30\text{ V}, V_{GS} = 0\text{ V}$		830		
	$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			1030		
	Q_G	Total Gate Charge	$V_{DS} = 30\text{ V}, V_{GS} = 5\text{ V}, I_D = 20\text{ A}$		8	11	nC
	Q_{GS}	Gate-to-Source Charge	$V_{DS} = 30\text{ V}, I_D = 20\text{ A}$		2.5		
	Q_{GD}	Gate-to-Drain Charge			1.5		
	$Q_{G(TH)}$	Gate Charge at Threshold			1.7		
	Q_{OSS}	Output Charge	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$		31	47	
	Q_{RR}	Source-Drain Recovery Charge			0		

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Figure 1 (Q1 & Q2): Typical Output Characteristics at 25°C

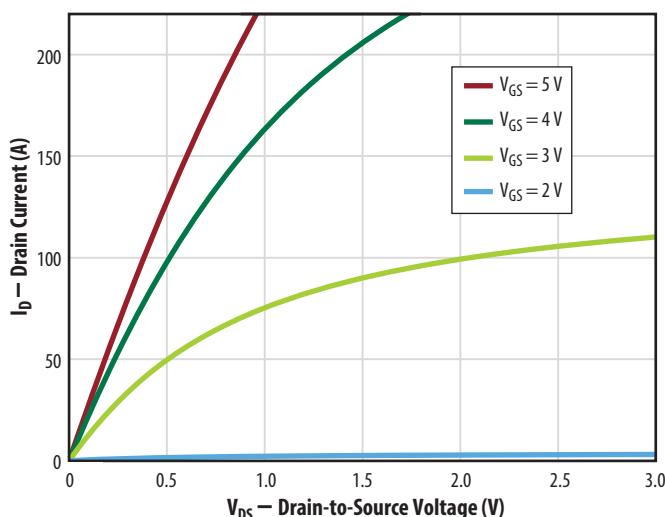


Figure 2 (Q1 & Q2): Transfer Characteristics

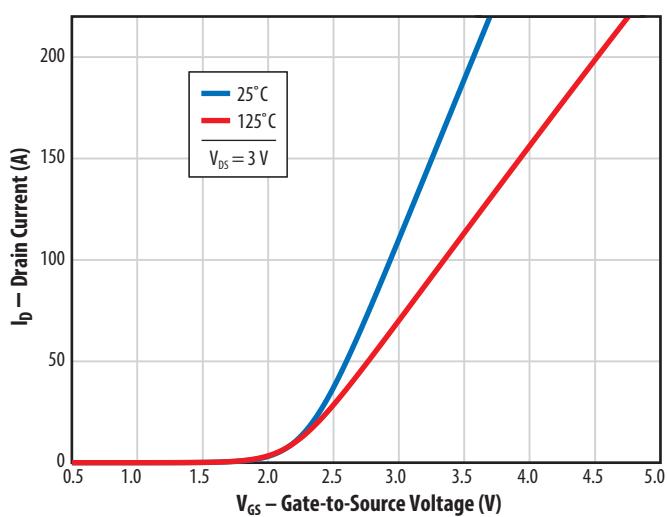
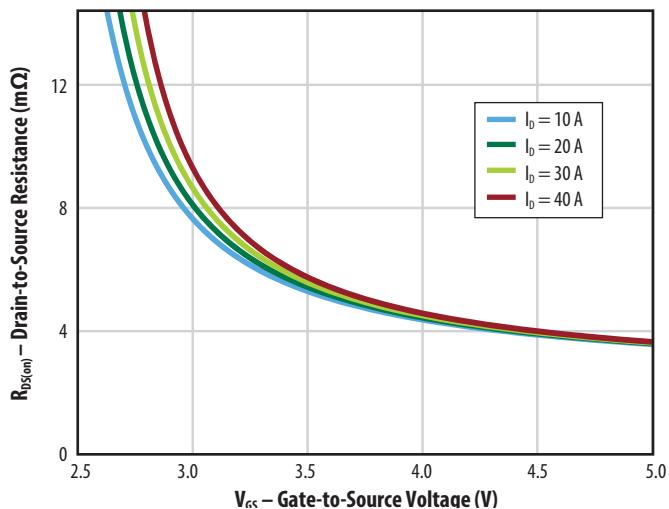
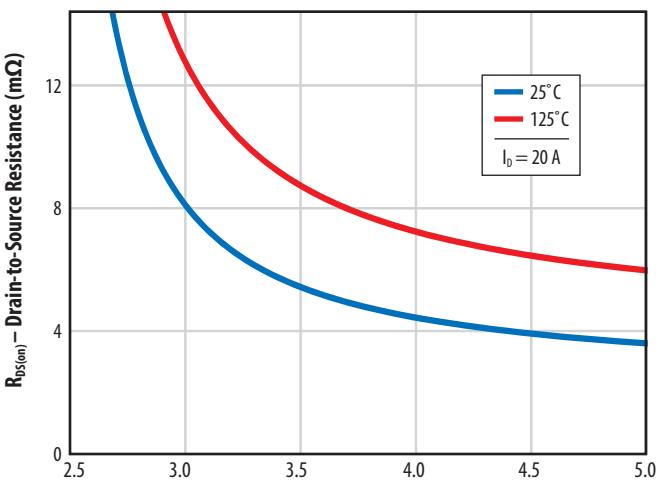
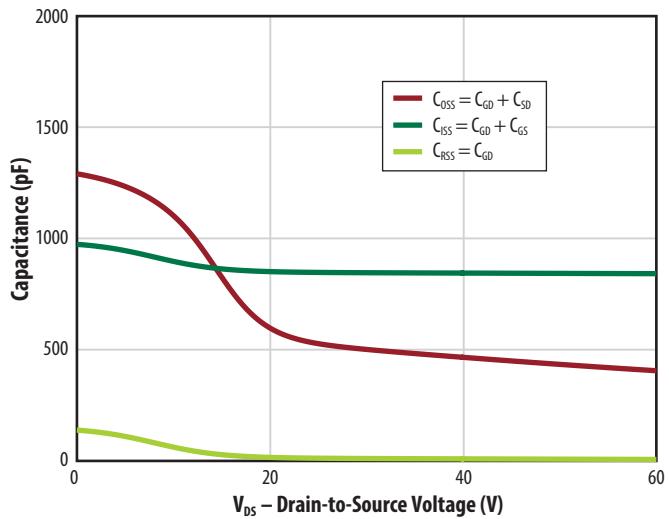
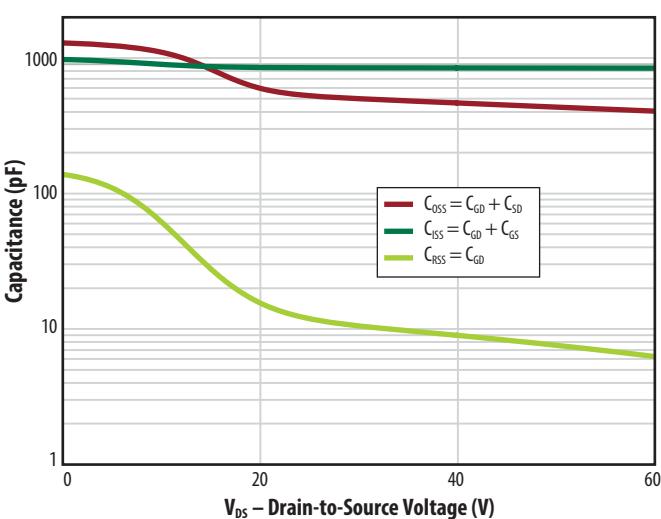
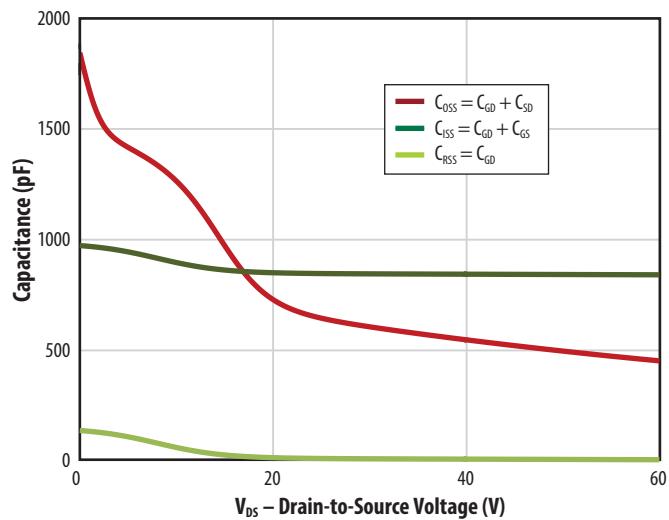
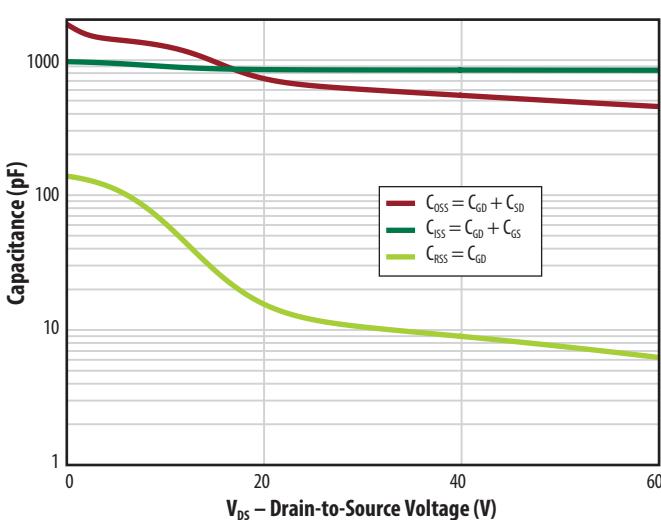


Figure 3 (Q1 & Q2): $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents**Figure 4 (Q1 & Q2): $R_{DS(on)}$ vs. V_{GS} for Various Temperatures****Figure 5a (Q1): Capacitance (Linear Scale)****Figure 5b (Q1): Capacitance (Log Scale)****Figure 5c (Q2): Capacitance (Linear Scale)****Figure 5d (Q2): Capacitance (Log Scale)**

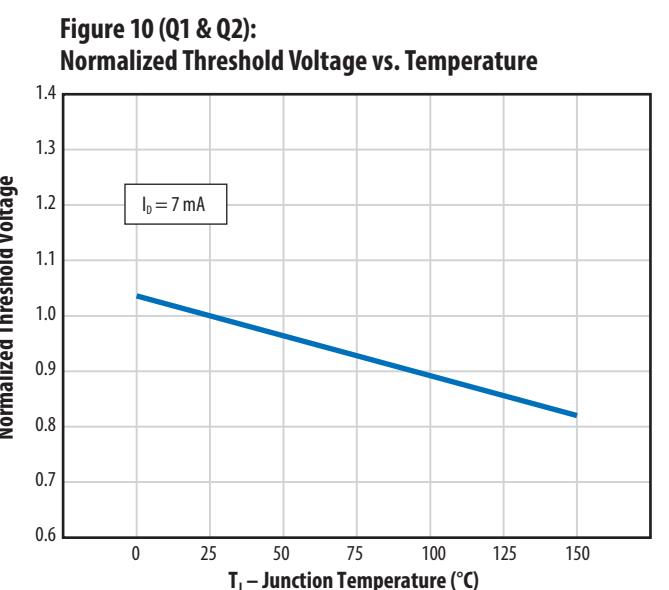
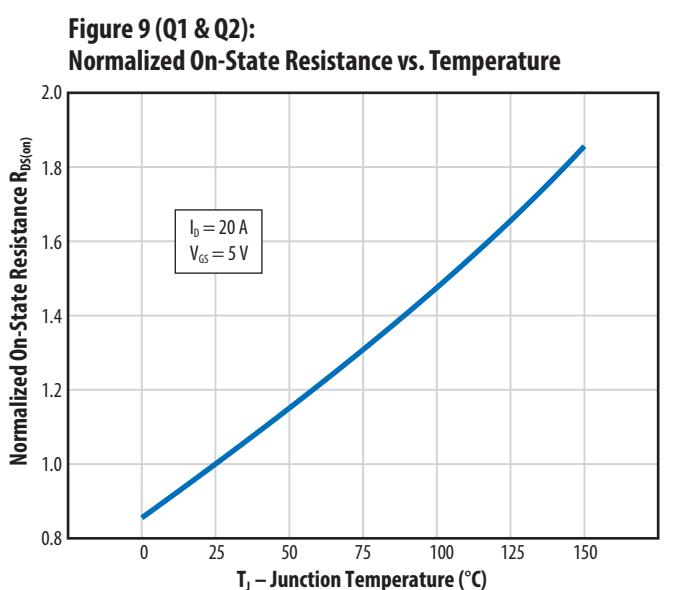
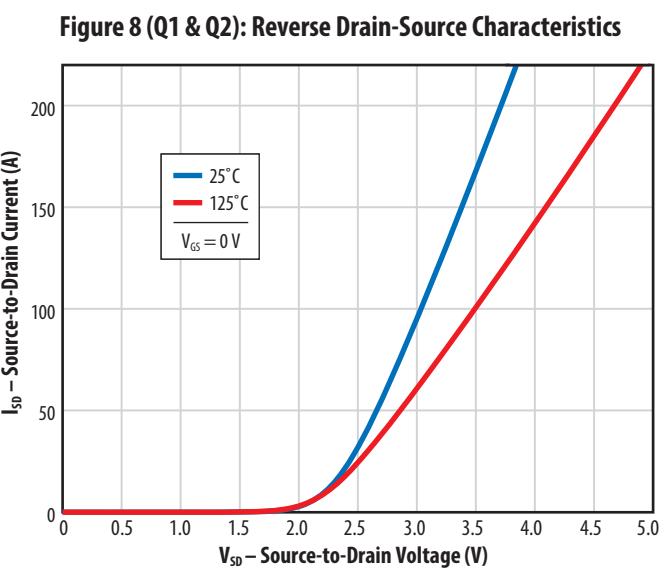
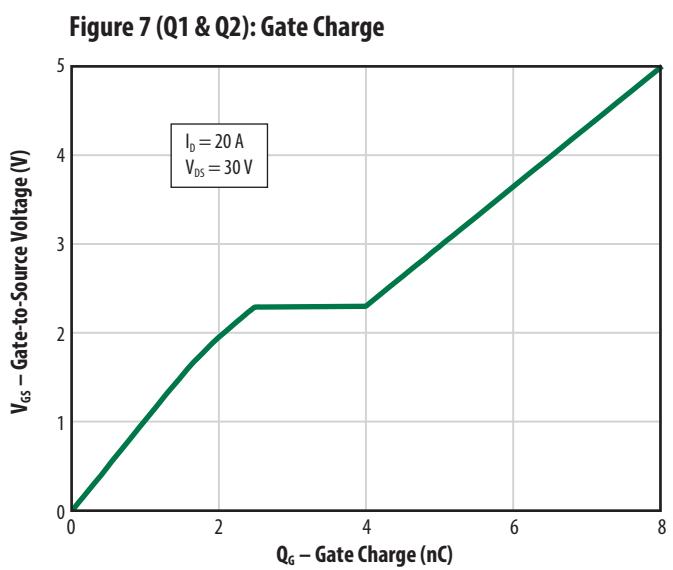
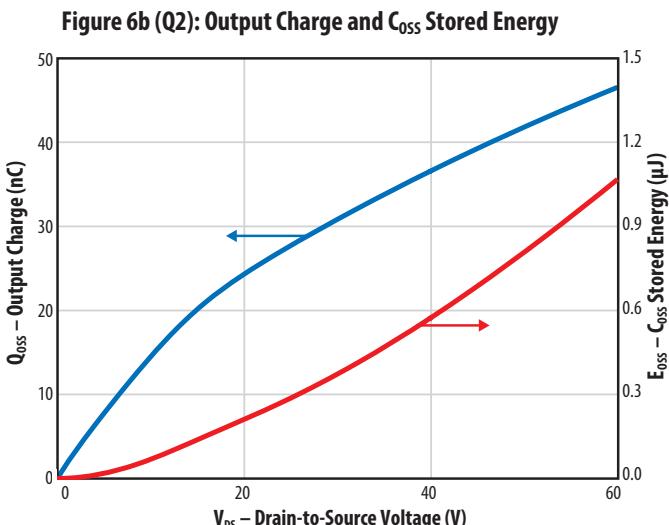
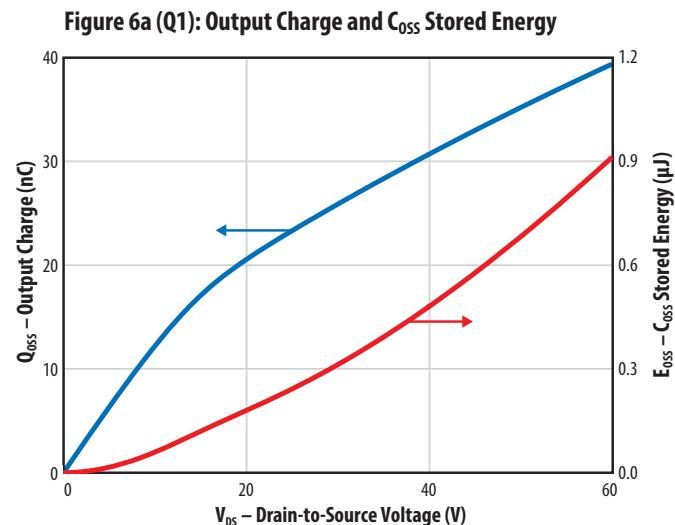


Figure 11a
Transient Thermal Response Curves

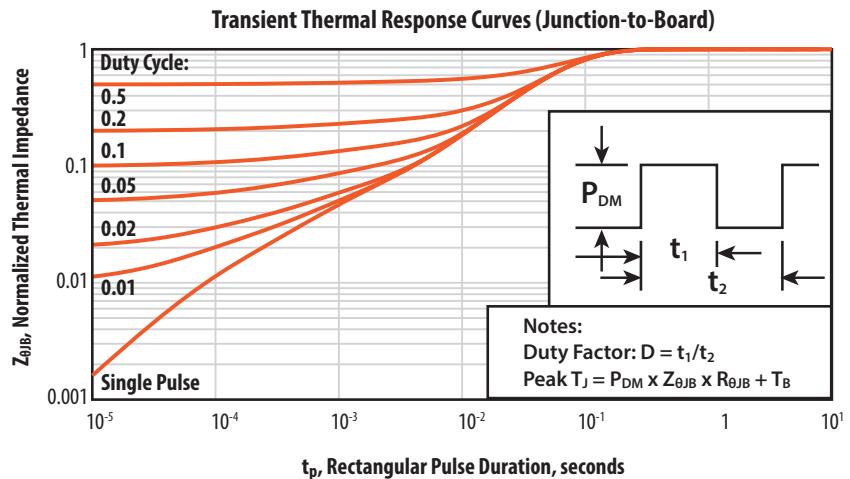


Figure 11b
Transient Thermal Response Curves

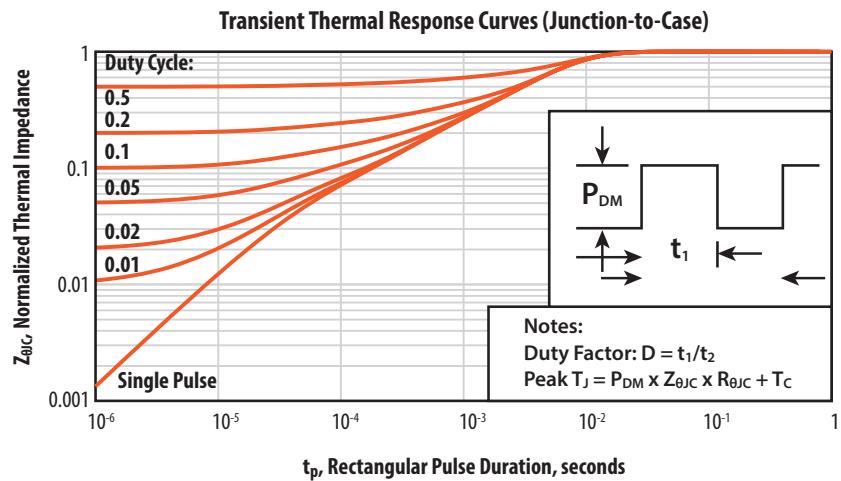


Figure 12 (Q1 & Q2): Safe Operating Area

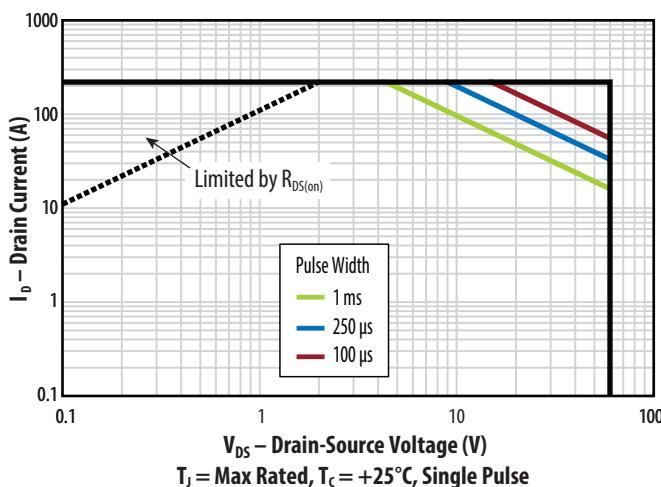
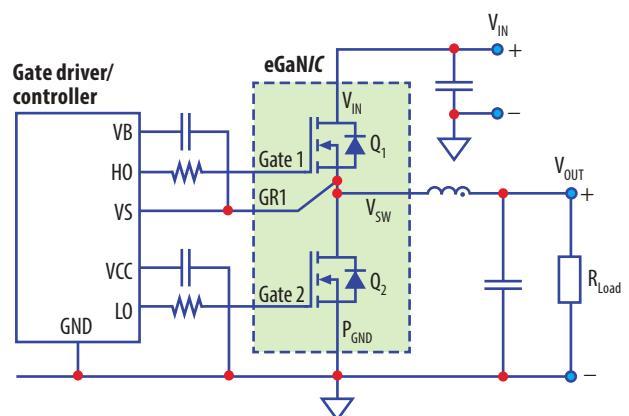
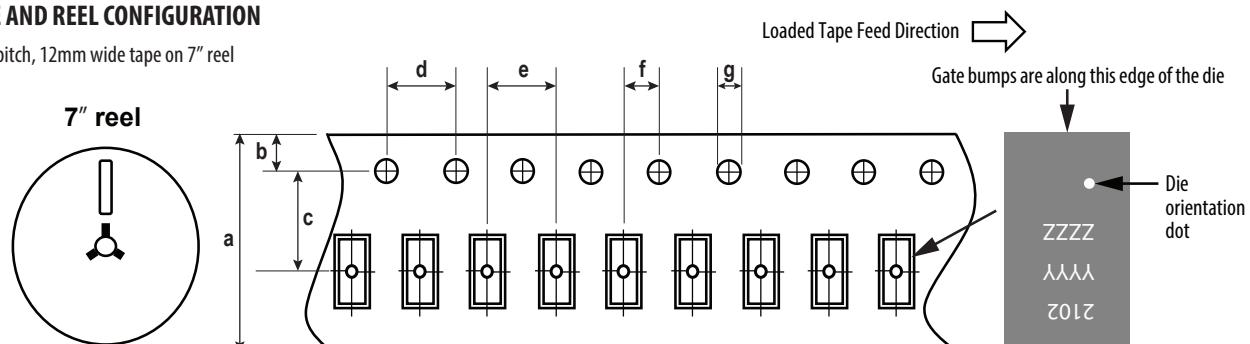


Figure 13: Typical Application Circuit



TAPE AND REEL CONFIGURATION

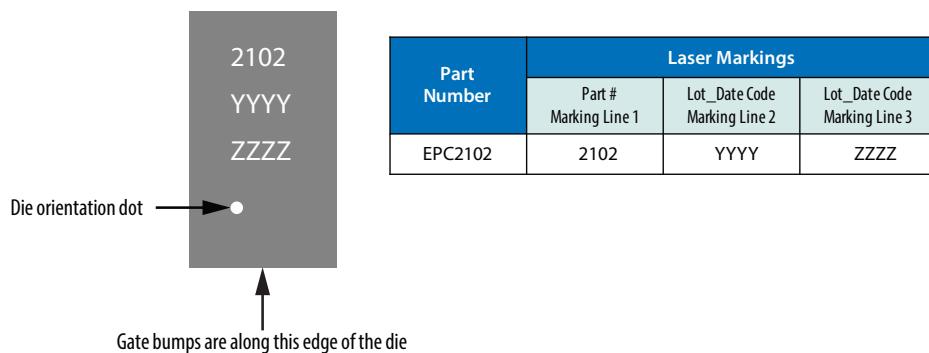
4mm pitch, 12mm wide tape on 7" reel



Die is placed into pocket
solder ball side down
(face side down)

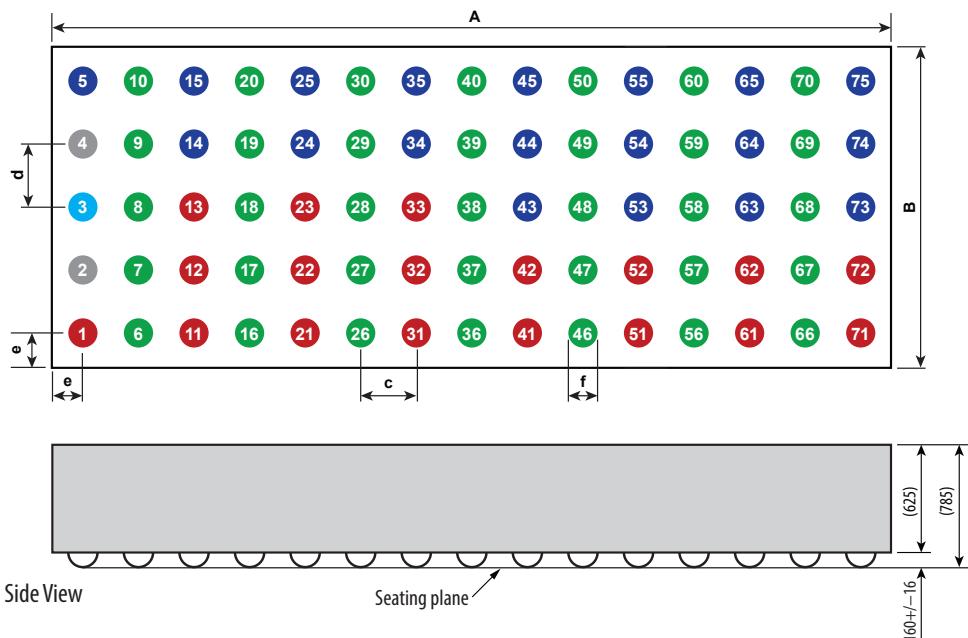
EPC2102 (note 1)			
Dimension (mm)	target	min	max
a	12.00	11.70	12.30
b	1.75	1.65	1.85
c (see note)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
g	1.50	1.50	1.60

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

DIE MARKINGS

DIE OUTLINE

Solder Bump View



DIM	MIN	Nominal	MAX
A	6020	6050	6080
B	2270	2300	2330
c	400	400	400
d	450	450	450
e	210	225	240
f	187	208	229

Pad 2 is G1; Pad 3 is Q1 Gate Return; Pad 4 is G2;

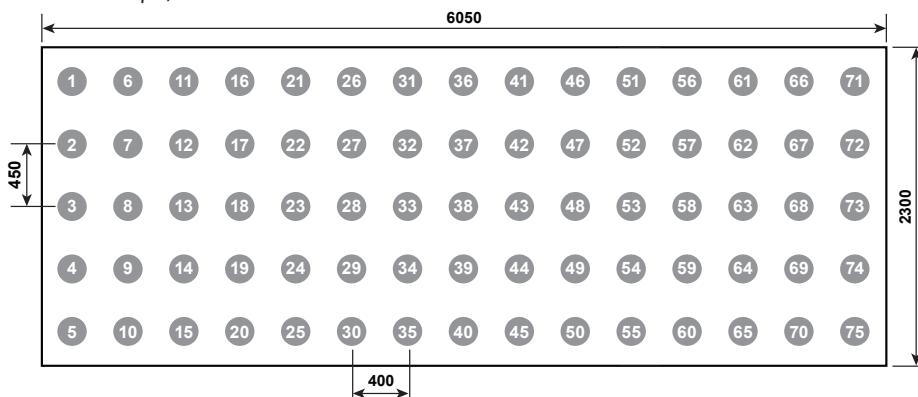
Pads 1, 11, 12, 13, 21, 22, 23, 31, 32, 33, 41, 42, 51, 52, 61, 62, 71, 72 are V_{IN};

Pads 5, 14, 15, 24, 25, 34, 35, 43, 44, 45, 53, 54, 55, 63, 64, 65, 73, 74, 75 Ground;

Pads 6, 7, 8, 9, 10, 16, 17, 18, 19, 20, 26, 27, 28, 29, 30, 36, 37, 38, 39, 40, 46, 47, 48, 49, 50, 56, 57, 58, 59, 60, 66, 67, 68, 69, 70 are Switch Node

RECOMMENDED LAND PATTERN

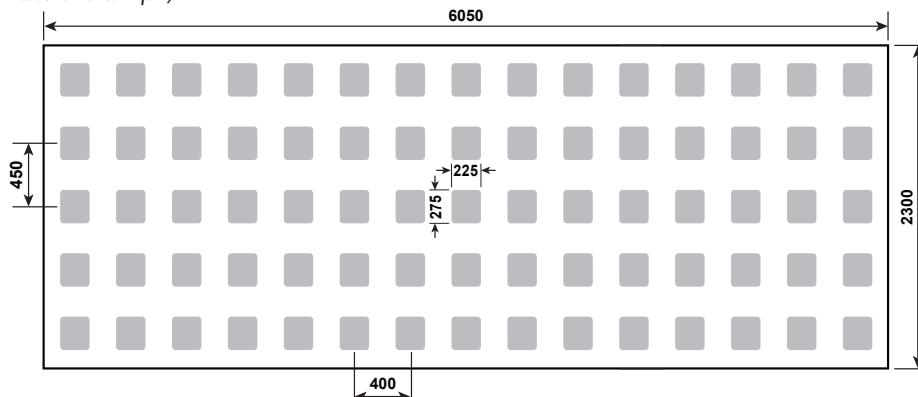
(measurements in µm)



The land pattern is solder mask defined.

Suggest SMD Pads at 200 +20/-10 µm.
190 µm minimum.**RECOMMENDED STENCIL DRAWING**

(measurements in µm)



Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder,
reference 88.5% metals content.Additional assembly resources available at:
[http://epc-co.com/epc/DesignSupport/
AssemblyBasics.aspx](http://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx)

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